



IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re Patent Application of

New York, New York

Takeshi Ootsuka

Date:

August 28, 2003

Serial No.:

10//615,895

Group Art Unit:

Filed:

July 9, 2003

Examiner:

N/A

For: ELECTRODE-BUILT-IN SUSCEPTOR

Commissioner for Patents P.O. Box 1450 Alexandria, VA 22313-1450

SUBMISSION

Sir:

On August 4, 2003, an Information Disclosure Statement and corresponding Form 1449 was submitted in connection with the instant application.

The Form 1449 inadvertently contained a clerical error in omitting the listing of U.S. Patent Documents 5,688,331; 2002/0006678 and 2003/008968 and JP 2001-308165 in the Foreign Patent Documents. Although all documents were included in the original submission, an additional copy of JP 2001-308165 is included herewith for the convenience of the Examiner. In accordance with the new rules of the Patent Office, no further copies of the U.S. patents have been included.

In the listing of Foreign Patent Documents and Other Documents, the Japanese Patent Documents No. JP-1-0189696 should be changed to JP-10-189696 and No. 2002-124296 should be changed to 2003-124296.

A corrected Form 1449 is hereby submitted.

I hereby certify that this correspondence is being deposited with the United States Postal Service as first class mail in an envelope addressed to: Commissioner for Patents P.O. Box 1450, Alexandria, VA 22313-1450, on August 28, 2003

Max Moskowitz

Name of applicant, assignee or Registered Representative

August 28, 2003

Date of Signature

Respectfully submitted,

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			Application 10/613,574 OFGS File No. P/2850-79					
APPLIC	CANT'S ART CITATI	ON Applican	Applicant Takeshi OOTSUKA					
(Use	e several sheets if necessary)	Filing Da	Filing Date July 9, 2003		Group Art Unit			
		U.S.	PATENT DOCUMENT	TS				
Examiner Initial	Document Number	Date MM-YYYY	Date M-YYYY Name		Sub- Filing Date class If Appropriate		g Date ropriate	
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